

### **Maximum Ratings**

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	65°C to +150°C
Ambient Temperature with Power Applied	40°C to +85°C
Supply Voltage to Ground Potential	0.5V to +4.6V
DC Input Voltage	0.5V to +5.5V
DC Output Current	120mA
Power Dissipation	0.5W
DC Input Voltage	-0.5V to +5.5V

#### Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

# **DC Electrical Characteristics** (Over Operating Range, $T_A = -40$ °C to +85°C, $V_{CC} = 3.3V \pm 10$ %)

Parameters	Description	Test Conditions <sup>(1)</sup>	Min.	Typ.(2)	Max.	Units	
$V_{\mathrm{IH}}$	Input HIGH Voltage	Guaranteed logic HIGH level	2.0		V <sub>CC</sub> +0.3V	V	
$V_{\mathrm{IL}}$	Input LOW Voltage	Guaranteed logic LOW level	-0.5		0.8	V	
$I_{IH}$	Input HIGH Current	$V_{CC} = Max., V_{IN} = V_{CC}$			±1		
$I_{\mathrm{IL}}$	Input LOW Current	$V_{CC} = Max., V_{IN} = GND$			±1	μA	
I <sub>OZH</sub>	High Impedance Output Current	$0 \le A, B \le V_{CC}$			±1	μπ	
	Switch On-Resistance	$V_{CC} = Min$ , $V_{IN} = 0V$ , $I_{ON} = -8mA$		5	8		
D		$V_{CC} = Min., V_{IN} = 1.7V, I_{ON} = -8mA$	= 1.7V, I <sub>ON</sub> = -8mA 15 22		Ω		
R <sub>ON</sub>		$V_{CC} = 2.3V., V_{IN} = 0V, I_{ON} = -8mA$		6	9		
		$V_{CC} = 2.3V$ ., $V_{IN} = 1.3V$ , $I_{ON} = -8mA$		25	30		
Va	Daga Valtaga	$V_{IN} = V_{CC} = 3.3V$ , $I_{OUT} = -5\mu A$	2.3	2.5	2.9	V	
Vp	Pass Voltage	$V_{IN} = V_{CC} = 2.5V$ , $I_{OUT} = -5\mu A$		1.8		V	

### Capacitance ( $T_A = 25$ °C, f = 1 MHz)

Parameters <sup>(5)</sup>	Description	Test Conditions	Тур.	Units	
$C_{IN}$	Input Capacitance	3.5			
C <sub>OFF</sub>	A/B Capacitance, Switch Off	$V_{IN} = 0V$	5.0	pF	
C <sub>ON</sub>	A/B Capacitance, Switch On	11.2			

#### **Notes:**

- 1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device type.
- 2. Typical values are at  $V_{CC} = 3.3V$ ,  $T_A = 25$ °C ambient and maximum loading.
- 3. Not more than one output should be shorted at one time. Duration of the test should not exceed one second.
- 4. Measured by the voltage drop between A and B pin at indicated current through the switch. On-Resistance is determined by the lower of the voltages on the two (A,B) pins.
- 5. This parameter is determined by device characterization but is not production tested.



### **Power Supply Characteristics**

Parameters	Description	Test Conditions <sup>(1)</sup>		Min.	<b>Typ.</b> <sup>(2)</sup>	Max.	Units
$I_{CC}$	Quiescent Power Supply Current	V Mov	$V_{IN} = GND \text{ or } V_{CC}$			3	4
$\Delta I_{CC}$	Quiescent Current per Input HIGH	$V_{CC} = Max.$	$V_{\rm IN} = 3V^{(3)}$			50	μΑ

#### **Notes:**

- 1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device.
- 2. Typical values are at  $V_{CC} = 3.3V$ , +25°C ambient.
- 3. Per driven input (control input only); A and B pins do not contribute to  $\Delta I_{CC}$ .

## Switching Characteristics over 3.3V ±0.3V Operating Range

Dayamataya	Description	Conditions <sup>(1)</sup>	Com.		II
Parameters	Description	Conditions	Min.	Max.	Units
t <sub>PLH</sub> t <sub>PHL</sub>	Propogation Delay <sup>(2,3)</sup> Ax to Bx	$C_{L} = 50 pF,$ $R_{L} = 500 \Omega$		0.25	
t <sub>PZH</sub> t <sub>PZL</sub>	Enable Time $\overline{BE}$ to Ax or Bx	$C_L = 50 \text{pF},$ $R_L = 500 \Omega,$	1.5	9.8	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Disable Time $\overline{BE}$ to Ax or Bx	$R_L = 500\Omega$ , $R = 500\Omega$	1.5	8.3	

### Switching Characteristics over 2.5V ±0.2V Operating Range

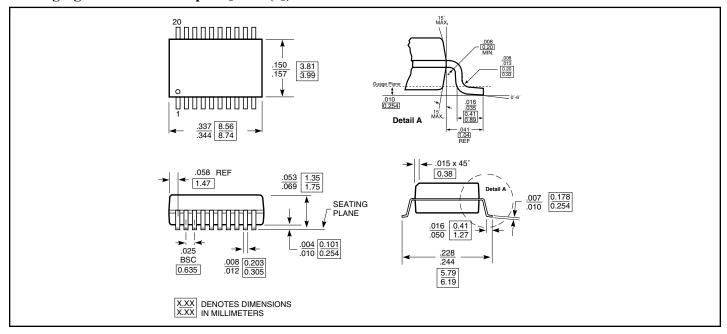
Danamatana	Description	Conditions <sup>(1)</sup>	Com.		17
Parameters		Conditions	Min.	Max.	Units
t <sub>PLH</sub> t <sub>PHL</sub>	Propogation Delay <sup>(2,3)</sup> Ax to Bx	$C_{L} = 50 \text{pF},$ $R_{L} = 500 \Omega$		0.25	
t <sub>PZH</sub> t <sub>PZL</sub>	Enable Time $\overline{BE}$ to Ax or Bx	$C_L = 50 \text{pF},$ $R_L = 500 \Omega,$	1.5	9.8	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Disable Time $\overline{BE}$ to Ax or Bx	$R_L = 500\Omega$ , $R = 500\Omega$	1.5	8.3	

#### **Notes:**

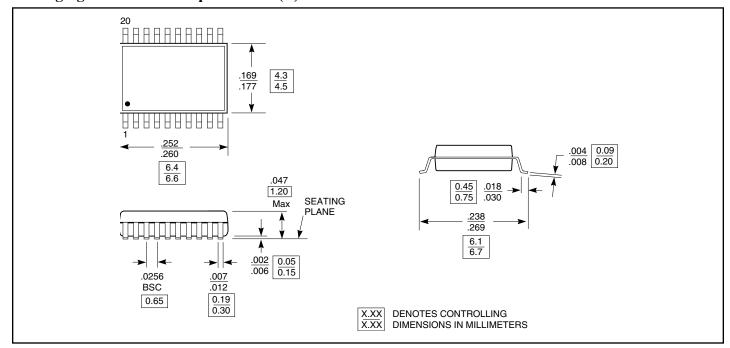
- 1. See test circuit and waveforms.
- 2. This parameter is guaranteed but not tested on Propagation Delays.
- 3. The bus switch contributes no propagational delay other than the RC delay of the On-Resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25ns for 50pF load. Since this time constant is much smaller than the rise/fall times of typical driving signals, it adds very little propagational delay to the system. Propagational delay of the bus switch when used in a system is determined by the driving circuit on the driving side of the switch and its interaction with the load on the driven side.



# Packaging Mechanical: 20-pin QSOP (Q)



## Packaging Mechanical: 20-pin TSSOP (L)



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# **Ordering Information**

Ordering Code	Packaging Code	Package Description
PI3VT3245L	L	20-pin TSSOP
PI3VT3245LE	L	Pb-free & Green, 20-pin TSSOP
PI3VT3245Q	Q	20-pin QSOP
PI3VT3245QE	Q	Pb-free & Green, 20-pin QSOP

### **Notes:**

<sup>1.</sup> Thermal characteristics can be found on the company web site at www.pericom.com/packaging/